

"Military Screening" Grade Two

### **Multi Layer Ceramic Capacitors**



#### 1. Features

- Rectangular, serialized size specifications, suitable for surface mount of hybrid integrated circuits or printed circuits;
- Lead type: radial lead, suitable for plug-in and wave soldering;
- There are a variety of end electrode lead-out materials for Ag (Cu)-Ni-Sn, which are especially suitable for the strict requirements of surface assembly technology for weldability and welding heat resistance.;
- Low inductance, low loss, good frequency characteristics, high reliability;
- National military standard production line production;
- Widely used in military communications, radar, artillery fuzes, ships, ground electronic equipment for aviation, aerospace, and weapon systems, and high-end civilian equipment.
- It is suitable for resonance circuits, coupling circuits and circuits that require low loss, high capacitance, stability and high insulation resistance in various types of military electronic equipment.

#### Purtnumber structure

FC4-	<u>683</u>	<u>X7R</u>	<u>1206</u>	<u>K</u>	<u>202</u>	<u>N</u>	<u>T</u>
				Ī	T	T	T
$\forall$	$\checkmark$	lack lack	$\checkmark$	ullet	ullet	ullet	$\mathbf{\Psi}$
1	2	3	4	(5)	6	7	8

#### **Description:**

#### 1 Product series.

FC4: Class I dielectric material type (COG)

FX4: Class II dielectric material type (Other TCC).

#### **②** Rated capacity code.

Capacity code	Actual value (pF)	Remark
0R5	0.5pF	
1R0	1.0pF	The first two digits are valid figures, and
472	47×10 <sup>2</sup>	the last digit is a power of 10.
104	10×10 <sup>4</sup>	



#### 3 Dielectric material.

Class I (FC4 series): C0G.

Class II (FX4 series): X7R, X5R, Y5V, Z5U, X6S, X7T, X7S and other materials.

#### 4 Size.

Dimensions	01005	0201	0402	0603	0805	1206	1210	1808	1812	2211
Length×Width (inch)	0.01×0.005	0.02×0.01	0.04×0.02	0.06×0.03	0.08×0.05	0.12×0.06	0.12×0.10	0.18×0.08	0.18×0.12	0.22×0.11
Length×Width (mm)	0.40×0.20	0.60×0.30	1.00×0.50	1.52×0.76	2.00×1.25	3.20×1.60	3.20×2.50	4.50×2.00	4.50×3.20	5.70×2.80

#### **⑤** Capacity tolerance level

code	Α	В	С	D.	f	G	J	K	М	L	Z	
tolerance	±0.05pF	±0.10pF	±0.25pF	±0.50pF	±1%	±2%	±5%	±10%	±20%	±30%	-20~+80%	
Remark		A, B, C, D tolerance level is generally used for ≤10pFcapacity										

### **6** Rated voltage

Voltage code	Actual value (V)	Remark
6R3	6.3	
500	50×10°	The first true digits are valid figures, and the last digit is 10
201	20×10¹	The first two digits are valid figures, and the last digit is 10 index of R as decimal point
102	10×10 <sup>2</sup>	'
202	20×10 <sup>2</sup>	

### **7** Terminal plating

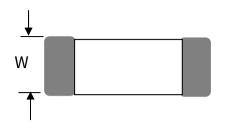
Terminal plating type	Plating Code
Three-layer plating Ag(Cu)/Ni/Sn	N
Silver	s
Gold	A
Tin/lead alloy containing at least 3% lead	Z

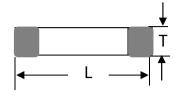
#### ® Packaging type

Packaging type	Packaging Code
Bulk	В
Taping	Т

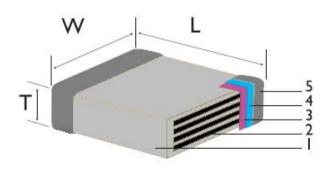


### Size specifications





Size	code		Size (mm)	
inch	mm	L	W	Tmax
01005	0402	0.40±0.02	0.20±0.02	0.22
0201	0603	0.60±0.05	0.30±0.05	0.35
0402	1005	1.00±0.20	0.50±0.20	0.70
0603	1608	1.52±0.25	0.76±0.25	1.01
0805	2012	2.00±0.25	1.25±0.25	1.45
1206	3216	3.20±0.30	1.60±0.30	1.80
1210	3225	3.20±0.30	2.50±0.30	2.80
1808	4520	4.50±0.40	2.00±0.20	2.80
1812	4532	4.50±0.40	3.20±0.30	3.10
2211	5728	5.70±0.50	2.80±0.30	3.10
2220	5750	5.70±0.50	5.00±0.50	4.90
2225	5763	5.70±0.50	6.30±0.50	6.20
3035	7689	7.60±0.50	9.00±0.50	6.20
3838	9696	9.80±0.50	9.20±0.50	4.50



Number	Item
1	ceramic dielectric
2	Internal electrode
3	External electrode
4	Nickel layer
5	Tin layer



#### Conventional voltage product capacity range

Specification (V)			0402			0603			0805				1206							
C <sub>R</sub> 6	6.3	10	16	25	50	6.3	10	16	25	50	6.3	10	16	25	50	6.3	10	16	25	50
100pF																				
220pF																				
330pF																				
470pF																				
680pF																				
1 nF																				
2.2nF																				
4.7nF																				
5.6nF																				
6.8nF																				
10nF																				
15nF																				
22nF																				
27nF																				
33nF																				
39nF																				
47nF																				
56nF																				
68nF																				
100nF																				
150nF																				
220nF																				
270nF																				
330nF																				
470nF																				
820nF																				
1.0uF																				
2.2uF																				
4.7uF																				
6.8uF																				
10uF																				
22uF																				
27uF																				
33uF																				
47uF																				
100uF																				

X7R X5R



### Medium and high voltage product capacity range

Specification	0		0805				1206					1210		
(V)	1	100	200	250	100	250	500	1000	2000	100	250	500	1000	2000
100pF														
150pF														
330pF														
470pF														
680pF														
1000pF														
1.2nF														
1.5nF														
2. 2nF														
3. 3nF														
4.7nF														
6.8nF														
10nF														
12nF														
15nF														
22nF														
27nF														
33nF														
39nF														
47nF														
56nF														
68nF														
100nF														
120nF														
150nF														
220nF														
270nF														
330nF														
470nF														
560nF														
1. OuF														
2. 2uF														



Specification				1808						1812			
(V)	100	250	500	1000	2000	3000	100	250	500	1000	2000	3000	4000
100pF													
150pF													
330pF													
470pF													
680pF													
1000pF													
1. 5nF													
2. 2nF													
2. 7nF													
3. 3nF													
4. 7nF													
6. 8nF													
10nF													
12nF													
15nF													
22nF													
27nF													
33nF													
39nF													
47nF													
56nF													
68nF													
100nF													
120nF													
150nF													
220nF													
270nF						_							
330nF													
470nF													
2. 2uF													



Specification	2225							
(V)	100	250	500	1000	2000	3000	4000	
100pF								
150pF								
180pF								
220pF								
330pF								
470pF								
680pF								
1000pF								
1.5nF								
2. 2nF								
3. 3nF								
4. 7nF								
6.8nF								
10nF								
12nF								
15nF								
22nF								
27nF								
33nF								
39nF								
47nF								
56nF								
68nF								
100nF								
120nF								
150nF								
220nF								
270nF								
330nF								
470nF								
820nF								
1uF								
2. 2uF								

Note: When customers have special requirements, please specify when ordering.



### **Product technical specifications**

Project		Technical Specifications/Test Methods							Remark		
	Class I	C0G:-55~+12	:5°C								
range of working temperature		first digit second digit third digit						hird digit	Foe example "X7		
		Lower limit			egory temperature		relatively to +25°C Capacity can chain full operating temperature range		The first letter "X" lowest operating t	emperature is -	-55℃.
		X:-55°C	_	:+65°C	7:+125°C		P:±10%	T:+22%/-33%	<ul> <li>The second digit ' highest operating</li> </ul>	'7" Indicates that temperature is	at its ⊧+125℃.
	Class II	Y:-30°C	5:	5:+85°C		8:+150°C		U:+22%/-56%	The third letter "F of Capacity can c ±15% when temp	hange not more	e than
		Z:+10°C	6:+105°C				S:±22%			ng temperature	range.
-								<u>.</u>	<u>'</u>		
Exterior		Visual inspe	ction, pro	oduct appea	rance has	no obvio	us defects		T		
				Nominal capacity Test frequency Te			ncy Test voltage	environment			
	Class I	Within specification error			<pre>&lt;1000pF 1MHz±10% &gt;1000pF 1KHz±10%</pre>		6 1.0±0.2Vrms				
Electrostatic	Class I						1KHz+10%	0% 1.0±0.2Vrms			
capacity									temperati	temperature: +25±2°C	
(C)					€1	0μF	1KHz±10%	6 1.0±0.2Vrms	Humidity: <75%		
	Class II	Within specification error			>1	0μF	120Hz/100H	120Hz/100Hz 0.5±0.2Vrms 1.0±0.1KHz 0.5±0.05Vrms			
						5U	1.0±0.1KH				
	Class I	Can≤50nF	F DF≪1 F	5×(150/CR+7	) × 10-4·	an≥50nF	DF≤0.15%		•		
			, 01 <1.5	7×(150/CK+1	,×10 , C	т т	, DI <0.1570	Ť	Í	-	
	Class II	Rated voltage	≥100V	50V	25 <b>V</b>		16V	10V	6. 3V		
		Except for Y5V and Z5U, other		≤3.5% (C<	1µF)	<b>≤</b> 5.0% (	C<1µF)	≤7.5% (С≤3.3µF)	≤7.5% (C<	3.3µF)	2
loss tangent		temperature characteristics,	≤2.5%	<7.5% (1µF	F <c<10μf) (1μf<c<<br="" <7.5%="">&gt;10μF) &lt;10.0% (C&gt;10μF</c<10μf)>		14F≪C<104F)	≤10.0% (C>3.3µF)	<10.0% (C≥3.3µF)		
(DF)		such as X7R/X5S		≤10.0% (C)			(C≥10⊬F)				
				≥25V 3.61				3.6V≤	≤U <sub>R</sub> <25V		
		Y5V	<		7.0% (C≤1μF)			.000			
		Z5U	8			9.0% (C>1µF)		<b>≤</b> 1	12.5%		
					Rated	oltage/	Test voltage	testing time	Charge and discharge	environm	ment
	Class I	C≤10nF Ri>	:10000M	10000MO				J	discharge current	CHVIIOIIII	iciic
Insulation resistance		C≤10nF,Ri≥10000MΩ C>10nF,Ri*Cr≥100S			Ur<1000V		Ur	60±5sec	<50mA		•-25±2°C
(IR)		C≤25nF,Ri≥4000MΩ C>25nF,Ri*CR>100S			Ur≽1000V 1000V			temperature:2 Humidity:<			
	Class II						1000V	60±5sec	<50mA		
				Rated voltage Test voltage		Slow rise time	testing time				
	Class I	Thomashouldhoo			Rated voltage Ur<200V		2.5Ur	0sec	1~5sec	environn	
Dielectric		There should be no breakdown or damage to the medium  (Extremely designed products such as  1206X7R102K282NB,2211C0G150Z722  N.B.Its "test voltage" is1.1Ur)			200V≤Ur≤1000V		1.5Ur	1~5sec	1~5sec	Humidity:	
strength (DWV)					Ur>1000V 1.2Ur		1~5sec	Charge and discharge cui			
(DWV)							3000A		-		
Capacity temperature coefficient or temperature characteristics				preprocessing(Ilkind):150+0/-10°C,1hrs,place24±2hrsAfter initial measurement, according to the following temperature sequence, the temperature is stable30minAfter measurement (△CbyT3shall prevail)							
	Class I	COG: 0±30ppm/°C									
					step T1			Temperature (°C) $20\pm2$			
	Class II	See the third digit in "Operating Temperature Range" number", such as "X7R", the third digit is "R",Right now"±15%".			T-2			Lower limit category temperature (e.g. X7R-55±3)			
					T3 20			20±2			
								Upper category temperature			
						T1 copper category temperatur			-		
	1				<del>                                     </del>						
					Soak the capacitor in ethanol and rosin (account25%weight) solution, take it out in 80~120  Preheat at °C temperature10~30sec, and then immerse it in the solder solution. Immersion tin						
	Class I	Nia odellele i				•			-		
Solderability	Class I	No visible da tin rate≥95%		appearance,	Preheat at	°C tempera	iture10~30sec, ar		solder solutio	n. Immersio	on tin



## **Product technical specifications**

	Exterior	No visible damage, tin coating rate ≥95%	Soak the capacitor in ethanol and rosin (account25%weight) solution, take it out in 100~				
		Ikind:±0.5%or ±0.5pF, whichever is greater	200Preheat at °C temperature10±2min, and then immerse it in the solder solution.				
Resistant to welding heat	△C/C	Ilkind:X7R X6S X5R X7S: ±10% X7T: ±15% Y5V Z5U: ±20%	Immersion tin temperature:260 $\pm$ 5°C; immersion tin speed: 25 $\pm$ 0.25mm/s Tin dipping time:10 $\pm$ 1sec				
	DF	Same as initial standard	After taking it out, clean it with solvent, and 100 bserve under a microscope at magnification.				
	IR	Same as initial standard	Place indoors after testing24±2hrsMeasure again later.				
		same as miliai stanuaru	Apply the right EN				
terminal electrode  Adhesion strength	The	terminal electrode does not peel off and there is no visible damage on the appearance.	time:10±1sec speed:1±0.5mm/sec capacitor PCBplate				
	Exterior	no visible damage	Test substrate:PCB 20 50 Bend depth:1mm				
Bending strength		Ikind:±5%	Pressure speed:1±0.5mm/sec. 零曲=1				
	△C/C	IIkind:±10%	Measurements should be made in the bent state.  电容测量仪 45 (in mm)				
	Exterior	no visible damage	preprocessing(Ilkind):150+0/-10°C,1hrs,place24±2hrsNumber of post-initial measurement cycles:5times,				
temperature cycle	△C/C	Ikind:±1%or±1pF  Whichever of the two is greater  IIkind:X7R X6S X5R X7S ±10%  X7T ±15%	one cycle is divided into the following4step: $ stage \qquad \qquad _{Temperature^*C} \qquad time  (minutes) $ $ No.1step \qquad \qquad _{Limit  category  temperature} \qquad 30 $ $ No.2step \qquad \qquad 20 \pm 2 \qquad \qquad 3 $				
		Z5U Y5V ±20%	10,2500				
	DF	Same as initial standard	No.3step Limit category temperature $30$ No.4step $20\pm2$ $3$				
	IR	Same as initial standard	Place indoors after testing24±2hrsMeasure again later.				
	Exterior	no visible damage					
		Ikind:±2%or±1pF					
		Whichever of the two is greater					
	△C/C	Ilkind:X7R X6S X5R X7S $\pm$ 10% X7T $\pm$ 15% Z5U Y5V $\pm$ 30%	temperature:40±2°C humidity:90~95%RH time:500+24/-0Hour				
steady state moisture test	DF	≤2times the initial standard	Storage conditions: Place at room temperature				
	IR	Ikind:Ri≥2500MΩorRi*C <sub>R</sub> >25S  Whichever of the two is smaller  IIkind:Ri≥1000MΩorRi*C <sub>R</sub> >25S  Whichever of the two is smaller	time:twenty fourHour(Ikind);48Hour(Ilkind)				
	Exterior	no visible damage					
Life test	△c/c	Ikind:±2%or±1pF Whichever of the two is greater IIkind:X7R X7T X6S X5R X7S	Rated voltage       Apply voltage         Ur<500V				
		±20% Z5U Y5V ±30%	Ur>1000V 1.30r				
	DF	≤2times the initial standard	Charge and discharge current: ≤50mA				
	IR	lkind:Ri≥4000MΩorRi*C <sub>R</sub> >40S	Temperature: upper limit category temperature				
		Whichever of the two is smaller	time:96±4Hour				
		Ilkind:Ri≥2000MΩorRi*C <sub>R</sub> >50S	Storage conditions: room temperature				
		•	Placement time:twenty fourHour(Ikind);48Hour(Ilkind)				



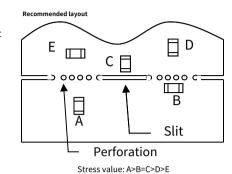
#### Precautions for use

#### 1. Precautions before use:

In the harsh working environment or external mechanical overpressure that exceeds the usage conditions stated in the relevant instructions of this acknowledgment, the MLCC chip may be damaged. Therefore, when using it, first consider applying according to the relevant instructions of this acknowledgment.

#### 2. PC board design

- 2.1 The amount of solder used will affect the chip's ability to withstand mechanical stress, which may cause the MLCC to break or crack. Therefore, when designing a substrate, careful consideration must be given to the size and configuration of the pads, which determine the amount of solder that makes up the substrate.
- 2.2 When designing the location of the pads and SMD MLCC, consideration should be given to minimizing stress, and the MLCC should be installed at the least affected location on the PC board.



3. Issues that should be considered during automatic installation

If the pickup tube is lowered beyond the lowest limit, excessive pressure will be exerted on the MLCC, causing the MLCC to rupture. When lowering the suction tube, pay attention to the following points:

- 3.1 After correcting the deviation of the PC board, the low limit of the pick-up tube should be adjusted to the horizontal position of the surface of the PC board
- 3.2 The suction pressure should be adjusted to between 1 and 3N.
- 3.3 In order to reduce the deformation of the PC board caused by the impact force of the suction pipe, the support nails should be placed under the PC board.

#### 4.Welding

4.1 MLCC is a combination of ceramic and metal.

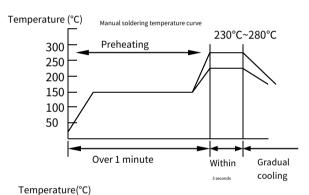
As a ceramic body, especially a large-sized ceramic body, Its thermoplasticity is poor and its response to heat is relatively slow. Ceramic bodies are prone to cracking when subjected to rapid cooling and heating. It is recommended to conduct continuous preheating for more than 1 minute before welding.

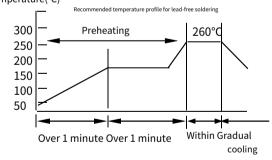
4.2 The interior of MLCC is a metal electrode.

It is very thermoplastic and responds quickly to heat. Thus, in When heated, metal parts and ceramic parts are bound to Expansion is inconsistent to a certain extent, resulting in internal Internal stress can easily cause the porcelain body to crack. It is recommended that before welding Perform continuous preheating for more than 1 minute.

4.3 When manual soldering, use the straight tip of the soldering iron with a constant temperature.
The maximum diameter is 1.0mm and the maximum power is 25 watts; the soldering iron cannot directly touch the MLCC components.

 $4.4\,lt\,is\,recommended\,to\,avoid\,using\,wave\,soldering\,for\,specifications\,above\,1206.$ 





#### 5.Cleaning

- $5.1\,\text{The temperature difference between the components and the cleaning process cannot be greater than 100°C.}$
- 5.2 In the case of ultrasonic cleaning, too much output power will cause the PC board to undergo excessive vibration, which will cause the MLCC or solder joints to crack, or reduce the strength of the terminal electrodes. Therefore, special attention should be paid to the following points:

Ultrasonic output: less than 20W/L; ultrasonic frequency: less than 40KHz; ultrasonic cleaning time: 5 minutes or less

#### 6. Cutting PCB board

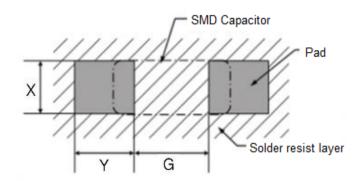
- 6.1 After installing the MLCC and other components, when dividing the PC board, be careful not to apply any force on the board. MLCC cannot be allowed to withstand excessive mechanical shock.
  6.2 The segmentation of boards cannot be done manually and appropriate equipment should be used.
- 7. Storage method

In order to maintain the solderability of the terminal electrodes and ensure that the packaging materials are in good condition, the recommended storage conditions are as follows: Storage temperature: 5-40°C; Storage relative humidity: 20-70%RH

Even when stored under ideal storage conditions, MLCC tip solderability will degrade over time, so MLCCs should be used within 6 months from the date of shipment.



## **Pad recommendation**



Reflow welding pad size									
Dimensions		à	×	(12:00	Y				
	min	max	min	max	min	max			
01005	0.16	0.20	0.20	0.23	0.12	0.18			
0201	0.20	0.30	0.25	0.40	0.20	0.30			
0402	0.40	0.60	0.40	0.60	0.30	0.50			
0603	0.50	1.00	0.60	1.00	0.60	0.80			
0805	0.60	1.20	0.90	1.60	0.70	1.30			
1206	1.80	2.50	1.20	2.00	1.00	1.60			
1210	1.80	2.50	1.80	3.20	1.00	1,60			
1812	2.50	3.70	2.30	3.50	1.20	1.90			
2220	3.20	4.70	3.50	5.00	1,20	2.30			
2225	3.20	4.70	3.50	6.80	1.20	2.30			
3035	3,30	6.00	8.00	9.50	1.60	3.00			
4045	7.00	8.60	10.80	12.00	1.60	3.00			
5868	11.50	13,20	16.50	18,20	1.60	3.00			